Power MOSFET 60 V, 39 mΩ, 17 A, Dual N–Channel, Logic Level, Dual SO8FL

Features

- Small Footprint (5x6 mm) for Compact Designs
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- 175°C Operating Temperature
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25° C unless otherwise noted)

| | | | , | | | |
|---|--|----------------------------|-----------------------------------|----------------|------|--|
| Parar | neter | | Symbol | Value | Unit | |
| Drain-to-Source Voltage | | V _{DSS} | 60 | V | | |
| Gate-to-Source Voltage | | V _{GS} | ±20 | V | | |
| Continuous Drain Cur- | | T _{mb} = 25°C | Ι _D | 17 | А | |
| rent R _{ΨJ-mb} (Notes 1, 2, 3, 4) | Steady | $T_{mb} = 100^{\circ}C$ | | 12 | | |
| Power Dissipation | State | T _{mb} = 25°C | PD | 23 | W | |
| $R_{\Psi J-mb}$ (Notes 1, 2, 3) | | $T_{mb} = 100^{\circ}C$ | | 12 | | |
| Continuous Drain Cur- rent $R_{\theta JA}$ (Notes 1 & 3, 4) Power Dissipation $R_{\theta, JA}$ (Notes 1, 3) | | T _A = 25°C | Ι _D | 6 | А | |
| | Steady State | T _A = 100°C | | 5 | | |
| | | T _A = 25°C | PD | 3.2 | W | |
| $R_{\theta JA}$ (Notes 1, 3) | | T _A = 100°C | | 1.6 | | |
| Pulsed Drain Current | T _A = 25 | °C, t _p = 10 μs | I _{DM} | 74 | А | |
| Operating Junction and | Storage T | emperature | T _J , T _{stg} | –55 to +175 | °C | |
| Source Current (Body D | iode) | | IS | 19 | А | |
| Single Pulse Drain- to-Source Avalanche | (I _{L(pk)} = 14.5 A, L = 0.1 mH) | | E _{AS} | 10.5 | mJ | |
| Energy (T _J = 25°C, V _{DD} = 24 V, V _{GS} = 10 V, R _G = 25 Ω) | (I _{L(pk)} = 6.3 A, L = 2 mH) | | | 40 | | |
| Lead Temperature for S (1/8" from case for 10 s) | | Purposes | ΤL | 260 | °C | |

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

| Parameter | Symbol | Value | Unit |
|--|-----------------|-------|------|
| Junction-to-Mounting Board (top) - Steady State (Note 2, 3) | $R_{\PsiJ-mb}$ | 6.5 | °C/W |
| Junction-to-Ambient - Steady State (Note 3) | $R_{\theta JA}$ | 47 | |

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Psi (Ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to single case surface.

3. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.

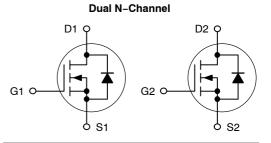
4. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

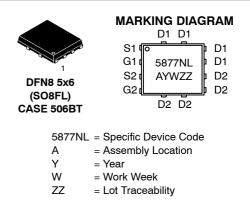


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| V _{(BR)DSS} | R _{DS(on)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| 60 V | 39 mΩ @ 10 V | 17 A |
| 60 V | 60 mΩ @ 4.5 V | 17.7 |





ORDERING INFORMATION

| Device | Package | Shipping [†] |
|----------------|-------------------|-----------------------|
| NVMFD5877NLT1G | DFN8 (Pb-Free) | 1500/Tape & Reel |
| NVMFD5877NLT3G | DFN8 (Pb-Free) | 5000/Tape & Reel |

+ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

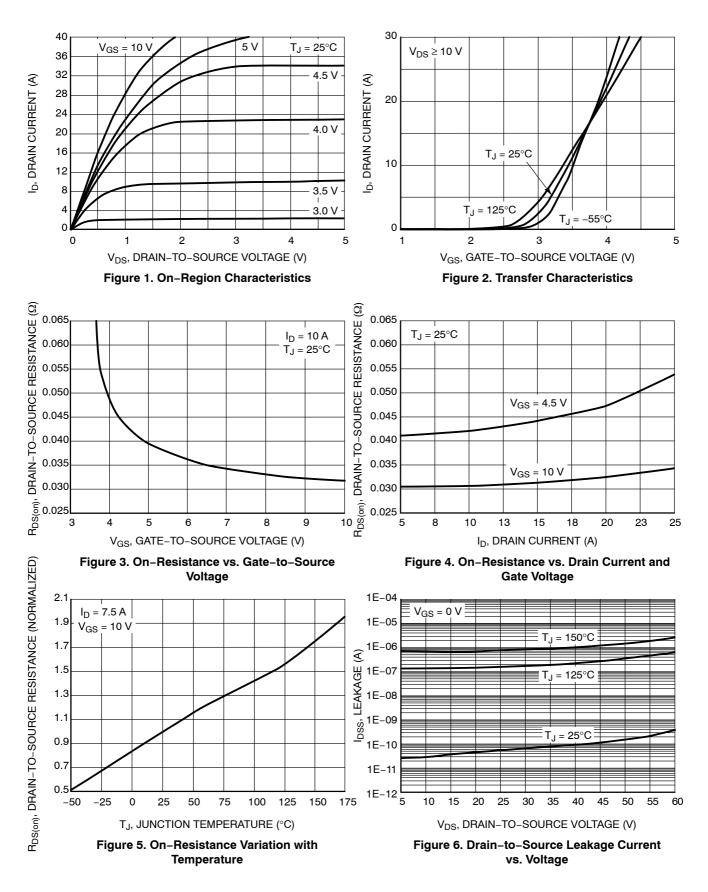
| Semiconductor Components Industries, LLC, 2013 | |
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ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

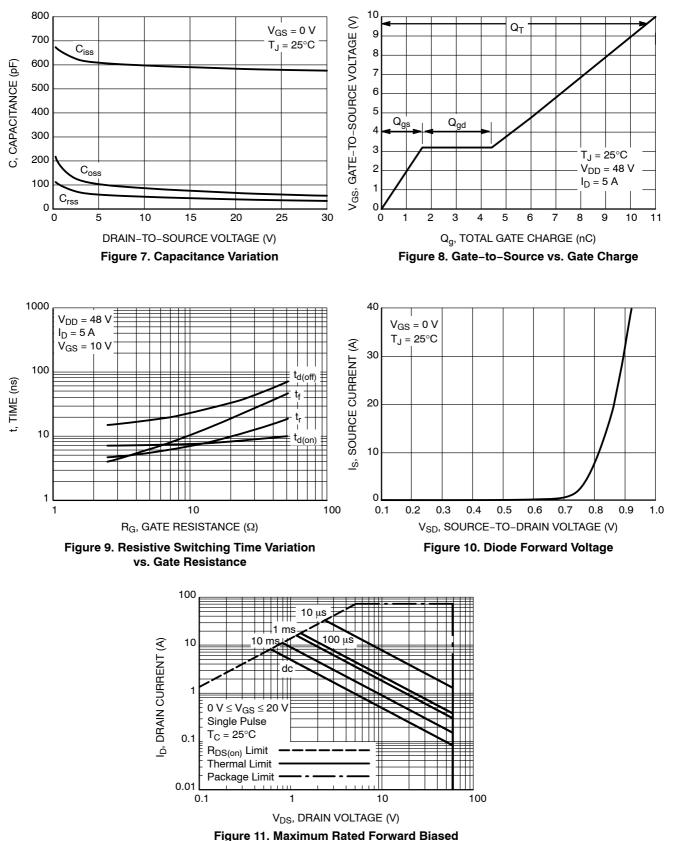
| Parameter | Symbol | Test Cond | ition | Min | Тур | Max | Unit |
|--|--------------------------------------|--|---------------------------|-----|-------|------|-------|
| OFF CHARACTERISTICS | | | | | | | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V _{GS} = 0 V, I _D = | 250 μA | 60 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | | | | 53 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{GS} = 0 V, | $T_J = 25^{\circ}C$ | | | 1.0 | μΑ |
| | | $V_{DS} = 60 V$ | T _J = 125°C | | | 10 | |
| Gate-to-Source Leakage Current | I _{GSS} | $V_{DS} = 0 V, V_{GS}$ | = ±20 V | | | ±100 | nA |
| ON CHARACTERISTICS (Note 5) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}, I_D =$ | = 250 μA | 1.0 | İ. | 3.0 | V |
| Negative Threshold Temperature Coefficient | V _{GS(TH)} /T _J | | | | 3.5 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = 10 V | I _D = 7.5 A | | 31 | 39 | mΩ |
| | | V _{GS} = 4.5 V | I _D = 7.5 A | | 42 | 60 | 1 |
| Forward Transconductance | 9 _{FS} | V _{DS} = 15 V, I _D | = 5.0 A | | 7.0 | | S |
| CHARGES AND CAPACITANCES | | | | | | | |
| Input Capacitance | C _{iss} | | | | 540 | | pF |
| Output Capacitance | C _{oss} | V_{GS} = 0 V, f = 1.0 MHz, V_{DS} = 25 V | | | 55 | | 1 |
| Reverse Transfer Capacitance | C _{rss} | | | | 36 | | |
| Total Gate Charge | Q _{G(TOT)} | | | | 5.9 | | nC |
| Threshold Gate Charge | Q _{G(TH)} | V _{GS} = 4.5 V, V _D | _S = 48 V, | | 0.62 | | 1 |
| Gate-to-Source Charge | Q _{GS} | $I_{\rm D} = 5.0 \rm{A}$ | | | 1.64 | | 1 |
| Gate-to-Drain Charge | Q _{GD} | | | | 2.80 | | |
| Total Gate Charge | Q _{G(TOT)} | V _{GS} = 10 V, V _{DS} = 4 | 8V, I _D = 5.0A | | 11 | 20 | nC |
| SWITCHING CHARACTERISTICS (No | ote 6) | | - | | | - | - |
| Turn-On Delay Time | t _{d(on)} | | | | 8.1 | | ns |
| Rise Time | t _r | V_{GS} = 4.5 V, V_{DS} = 48 V, I_{D} = 5.0 A, R_{G} = 2.5 Ω | | | 15.8 | | |
| Turn-Off Delay Time | t _{d(off)} | | | | 11.8 | | 1 |
| Fall Time | t _f | | | | 3.9 | | 1 |
| Turn-On Delay Time | t _{d(on)} | | | | 4.9 | | ns |
| Rise Time | tr | V _{GS} = 10 V, V _D | ₃ = 48 V, | | 6.4 | | |
| Turn-Off Delay Time | t _{d(off)} | I _D = 5.0 A, R _G | = 2.5 Ω | | 14.5 | | _ |
| Fall Time | t _f | | | | 2.4 | | |
| DRAIN-SOURCE DIODE CHARACTE | ERISTICS | | | | | | |
| Forward Diode Voltage | V _{SD} | V _{GS} = 0 V, | $T_J = 25^{\circ}C$ | | 0.8 | 1.2 | V |
| | | V _{GS} = 0 V, I _S = 5.0 A | T _J = 125°C | | 0.7 | | |
| Reverse Recovery Time | t _{RR} | | • | | 14.5 | | ns |
| Charge Time | t _a | $\label{eq:VGS} \begin{array}{l} V_{GS} = 0 \ V, \ d_{IS}/d_t = 100 \ A/\mu s, \\ I_S = 5.0 \ A \end{array}$ | | | 11.5 | |] |
| Discharge Time | t _b | | | | 3.1 | | 1 |
| Reverse Recovery Charge | Q _{RR} | | | | 11 | | nC |
| PACKAGE PARASITIC VALUES | | | | | | | |
| Source Inductance | L _S | T _A = 25°C | | | 0.93 | | nH |
| Drain Inductance | L _D | | | | 0.005 | | |
| Gate Inductance | L _G | | | | 1.84 | | |
| Gate Resistance | R _G | | | | 1.5 | | Ω |

 $\begin{array}{ll} \text{5. Pulse Test: pulse width = 300 } \mu\text{s, duty cycle } \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



Safe Operating Area

TYPICAL CHARACTERISTICS

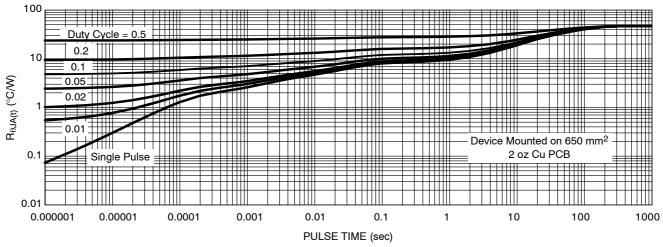
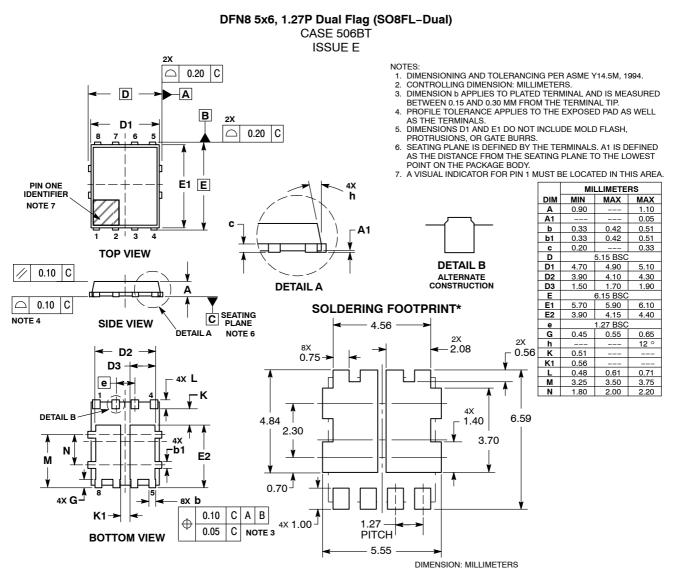


Figure 12. Thermal Response

PACKAGE DIMENSIONS



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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